Search Notes

Application/C	ontrol No.	
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10/705,892 Examiner

Jacques Veillard

Applicant(s)/Patent under Reexamination

LEE, SU-JEONG

Art Unit

2165

SEARCHED			
Class	Subclass	Date	Examiner
707	2, 203	5/22/2006	J.V
707	103R	5/22/2006	J.V
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EIC Plus database search	4/17/2006	J.V
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